Search Notes			

Application/Control No.	Applicant(s)/Patent Reexamination	under
10/033,897	NAKAMURA ET AI	- •
Examiner	Art Unit	
Edward J. Cain	1714	

SEADONED					
	SEARCHED				
Class	Subclass	Date	Examiner		
524	1				
528	502R	3/5/2007	EC		
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
524	1		
528	502R	3/5/2007	EC

SEARCH (INCLUDING SEAR	NOTES CH STRATEG	r)
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